

<b>Notice of References Cited</b>	Application/Control No. 10/754,530		Applicant(s)/Patent Under Reexamination TSURUYA, TAKAAKI	
	Examiner Hai C. Pham		Art Unit 2861	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,504,147	01-2003	Ito et al.	250/234
*	B	US-5,887,124	03-1999	Iwasaki et al.	358/1.9
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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